### Application/Control No. Applicant(s)/Patent Under Reexamination 10/081,345 KARPF ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1623 Devesh Khare **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 08-2002 560/125 US-6,437,171 B1 Karpf et al. Α US-В US-Ç US-D US-Ε US-F US-G USн US-US-J Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 P a R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U Auge et al. Tetrahedron Letters, 37(43), pp 7715-7716, 1996. W

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